

Search Notes

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Examiner

Erin M. File

Applicant(s)/Patent under
Reexamination

CHANG ET AL.

Art Unit

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SEARCHED

Class	Subclass	Date	Examiner
375	354	7/17/2005	EMF

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
375	354	7/17/2005	EMF

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST US PAT, USPGPUB, EPO, JPO DERWENT, IBM See Search History Printout	7/17/2005	EMF
PALM INVENTORSHIP	7/17/2005	EMF
370/503 (text search only-see search history printout)	7/17/2005	EMF
709/248 (text search only-see search history printout)	7/17/2005	EMF
327/141 (text search only-see search history printout)		